

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/724,365	OSAME ET AL.		
Examiner	Art Unit		
Long Nguyen	2816		

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Class	Subclass	Date	Examiner
327	198,217,219 218,208) 210,91, 93-95,	3/24/05	LN
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